Search I	<b>Notes</b>
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/690,957	OGAWA ET AL
Examiner	Art Unit
Binh C. Tat	2825

SEARCHED				
Class	Subclass	Date	Examiner	
716	2,18	3/5/2005	вт	
703	14,15	3/5/2005	вт	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
716	2,18	3/5/2005	ВТ	
L				

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST SEARCH	3/5/2005	ВТ